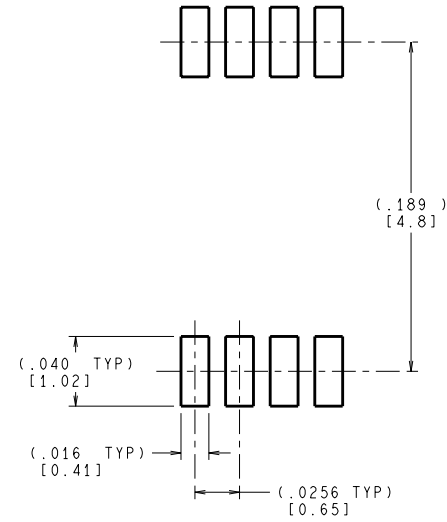
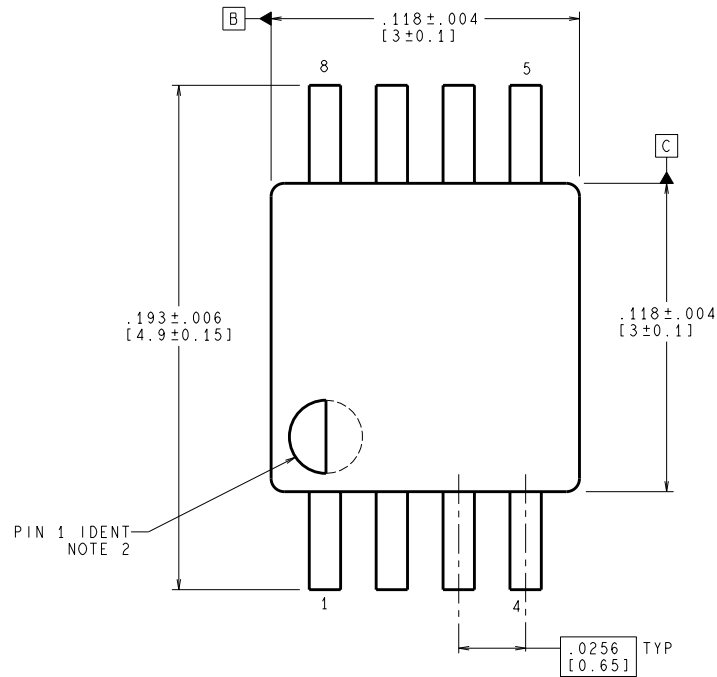
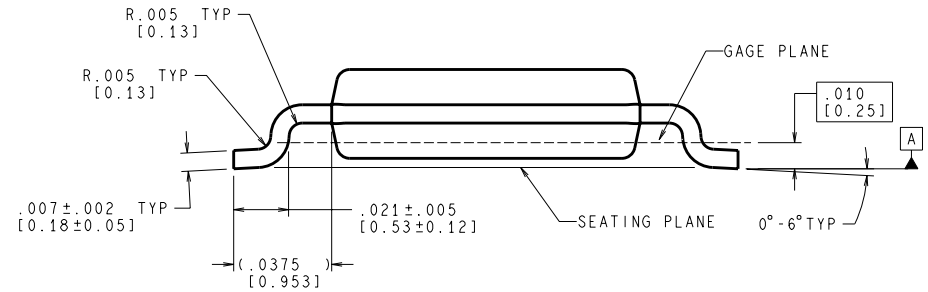
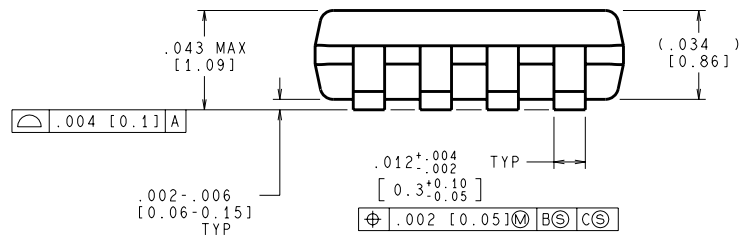


REVISIONS				
LTR	DESCRIPTION	E.C.N.	DATE	BY/APP'D
A	RELEASE TO DOCUMENT CONTROL	11620	11/18/1996	TL/FL
B	DIM .043 MAX WAS .030-.037; DIM (.034) WAS (.033); DIM .193±.006 WAS .193±.004	11634	01/07/1997	MS/FL
C	COPLANARITY .004[0.1] WAS .002[0.05]; NOTE 1: 200 WAS 150, 5.08 WAS 3.81	11932	02/24/1998	MS/CD
D	DIM .043 MAX WAS .034	12170	03/12/1999	MS/



LAND PATTERN RECOMMENDATION



**CONTROLLING DIMENSION IS INCH
VALUES IN [] ARE MILLIMETERS**

NOTES: UNLESS OTHERWISE SPECIFIED

- STANDARD LEAD FINISH TO BE 200 MICRONS/ 5.08 MICROMETERS MINIMUM TIN/LEAD (SOLDER) ON COPPER.
- PIN 1 IDENTIFICATION TO HAVE HALF OR FULL CIRCLE OPTION.
- REFERENCE JEDEC REGISTRATION MO-187, VARIATION AA, DATED MAR 1996.

APPROVALS	DATE	National Semiconductor			
DRAWN T. LEQUANG	11/18/1996	2900 Semiconductor dr. Santa Clara, CA 95052-8090			
DFTG. CHK.		MOLDED PACKAGE, MINI-SO, .118 WIDE, 8 LEAD			
ENGR. CHK.					
		SCALE	SIZE	DRAWING NUMBER	REV
		N/A	C	(SC)MKT-MUA08A	D
		DO NOT SCALE DRAWING			SHEET 1 of 1